Se	arcn Notes	,

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/531,851	TREMBLE ET AL.	
Examiner	Art Unit	
Shin-Lin Chen	1632	

SEARCHED			
Class	Subclass	Date	Examiner
514	44		
536	23.1		
536	23.5		
435	320.1		
435	455		
424	93.21	1/18/2007	Su.
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST, STN, Medline, Caplus, Biosis, Scisearch, Lifesci, parents reviewed and updated.	1/18/2007	Gu.